Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/519,599	LEE ET AL.
Examiner	Art Unit
David Y. Chung	2871

SEARCHED				
Class	Subclass	Date	Examiner	
349	65	3/5/2007	DC	
349	58	3/5/2007	DC	
362	615	3/5/2007	DC	
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
same	9/4/2007	DC		
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	Subclass same	Subclass Date same 9/4/2007		

SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
EAST search report	3/5/2007	DC
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